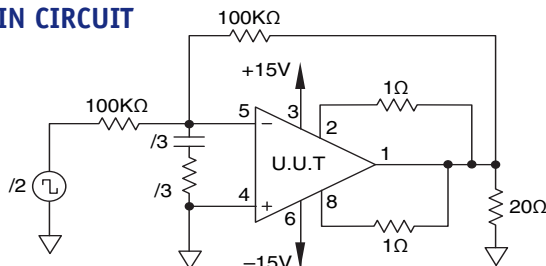


PA12M/883

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SG	PARAMETER	SYMBOL	TEMP.	POWER	TEST CONDITIONS	MIN	MAX	UNITS
1	Quiescent current	I_Q	25°C	±40V	$V_{IN} = 0, A_V = 100, R_{CL} = .1\Omega$		50	mA
1	Input offset voltage	V_{OS}	25°C	±40V	$V_{IN} = 0, A_V = 100$		±6	mV
1	Input offset voltage	V_{OS}	25°C	±10V	$V_{IN} = 0, A_V = 100$		±12	mV
1	Input offset voltage	V_{OS}	25°C	±45V	$V_{IN} = 0, A_V = 100$		±7	mV
1	Input bias current, +IN	$+I_B$	25°C	±40V	$V_{IN} = 0$		±30	nA
1	Input bias current, -IN	$-I_B$	25°C	±40V	$V_{IN} = 0$		±30	nA
1	Input offset current	I_{OS}	25°C	±40V	$V_{IN} = 0$		±30	nA
3	Quiescent current	I_Q	-55°C	±40V	$V_{IN} = 0, A_V = 100, R_{CL} = .1\Omega$		100	mA
3	Input offset voltage	V_{OS}	-55°C	±40V	$V_{IN} = 0, A_V = 100$		±11.2	mV
3	Input offset voltage	V_{OS}	-55°C	±10V	$V_{IN} = 0, A_V = 100$		±17.2	mV
3	Input offset voltage	V_{OS}	-55°C	±45V	$V_{IN} = 0, A_V = 100$		±12.2	mV
3	Input bias current, +IN	$+I_B$	-55°C	±40V	$V_{IN} = 0$		±115	nA
3	Input bias current, -IN	$-I_B$	-55°C	±40V	$V_{IN} = 0$		±115	nA
3	Input offset current	I_{OS}	-55°C	±40V	$V_{IN} = 0$		±115	nA
2	Quiescent current	I_Q	125°C	±40V	$V_{IN} = 0, A_V = 100, R_{CL} = .1\Omega$		50	mA
2	Input offset voltage	V_{OS}	125°C	±40V	$V_{IN} = 0, A_V = 100$		±12.5	mV
2	Input offset voltage	V_{OS}	125°C	±10V	$V_{IN} = 0, A_V = 100$		±18.5	mV
2	Input offset voltage	V_{OS}	125°C	±45V	$V_{IN} = 0, A_V = 100$		±13.5	mV
2	Input bias current, +IN	$+I_B$	125°C	±40V	$V_{IN} = 0$		±70	nA
2	Input bias current, -IN	$-I_B$	125°C	±40V	$V_{IN} = 0$		±70	nA
2	Input offset current	I_{OS}	125°C	±40V	$V_{IN} = 0$		±70	nA
4	Output voltage, $I_O = 10A$	V_O	25°C	±16V	$R_L = 1\Omega$	10		V
4	Output voltage, $I_O = 80mA$	V_O	25°C	±45V	$R_L = 500\Omega$	40		V
4	Output voltage, $I_O = 5A$	V_O	25°C	±35V	$R_L = 6\Omega$	30		V
4	Current limits	I_{CL}	25°C	±14V	$R_L = 6\Omega, R_{CL} = 1\Omega$	.6	.89	A
4	Stability/noise	E_N	25°C	±40V	$R_L = 500\Omega, C_L = 1.5nF, /1$		1	mV
4	Slew rate	SR	25°C	±40V	$R_L = 500\Omega$	2.5	10	V/μs
4	Open loop gain	A_{OL}	25°C	±40V	$R_L = 500\Omega, F = 10Hz$	96		dB
4	Common mode rejection	CMR	25°C	±15V	$R_L = 500\Omega, F = DC, V_{CM} = \pm 9V$	74		dB
6	Output voltage, $I_O = 8A$	V_O	-55°C	±14V	$R_L = 1\Omega$	8		V
6	Output voltage, $I_O = 80mA$	V_O	-55°C	±45V	$R_L = 500\Omega$	40		V
6	Stability/noise	E_N	-55°C	±40V	$R_L = 500\Omega, C_L = 1.5nF, /1$		1	mV
6	Slew rate	SR	-55°C	±40V	$R_L = 500\Omega$	2.5	10	V/μs
6	Open loop gain	A_{OL}	-55°C	±40V	$R_L = 500\Omega, F = 10Hz$	96		dB
6	Common mode rejection	CMR	-55°C	±15V	$R_L = 500\Omega, F = DC, V_{CM} = \pm 9V$	74		dB
5	Output voltage, $I_O = 8A$	V_O	125°C	±14V	$R_L = 1\Omega$	8		V
5	Output voltage, $I_O = 80mA$	V_O	125°C	±45V	$R_L = 500\Omega$	40		V
5	Stability/noise	E_N	125°C	±40V	$R_L = 500\Omega, C_L = 1.5nF, /1$		1	mV
5	Slew rate	SR	125°C	±40V	$R_L = 500\Omega$	2.5	10	V/μs
5	Open loop gain	A_{OL}	125°C	±40V	$R_L = 500\Omega, F = 10Hz$	96		dB
5	Common mode rejection	CMR	125°C	±15V	$R_L = 500\Omega, F = DC, V_{CM} = \pm 9V$	74		dB

BURN IN CIRCUIT



- /1 Minimum gain recommendation is either $G = +4$ (non-inverting) or $G = -3$ (inverting).
- /2 Input signals are calculated to result in internal power dissipation of approximately 2.1W at case temperature = 125°C.
- /3 These components are used to stabilize device due to poor high frequency characteristics of burn in board.